Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/644,136	TAKANO ET AL.	
Examiner	Art Unit	

Stephen M. Brinich

2625

SEARCHED						
Class	Şubclass	Date	Examiner			
358	1.15-1.18, 1.9, 2.1, 406, 504	4/25/2007	SMB			
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
WEST (Search Printout)	4/25/2007	SMB
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